Unit: mm

#### TOSHIBA Transistor Silicon NPN Epitaxial Type

# 2SC6075

# Power Amplifier Applications Power Switching Applications

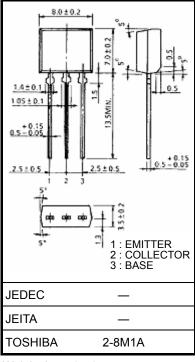
Low collector emitter saturation voltage

 $: V_{CE (sat)} = 0.5 \text{ V (max)} (I_{C} = 1A)$ 

High-speed switching:  $t_{stg} = 0.4 \mu s$  (typ)

#### **Absolute Maximum Ratings (Ta = 25°C)**

Characteristic		Symbol	Rating	Unit	
Collector-base voltage	$V_{CBO}$	160	V		
Collector-emitter voltage		V <sub>CEX</sub>	160	V	
		V <sub>CEO</sub>	80	V	
Emitter-base voltage		V <sub>EBO</sub>	9	V	
Collector current	DC	IC	2.5	Α	
	Pulse	I <sub>CP</sub>	5.0	Α	
Base current		ΙΒ	1.0	Α	
Collector power dissipation		PC	1.3	W	
Junction temperature	Tj	150	°C		
Storage temperature range		T <sub>stg</sub>	-55~150	°C	



Weight:0.55g(typ)

Note: Using continuously under heavy loads (e.g. the application of high

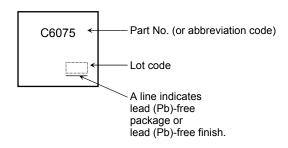
temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

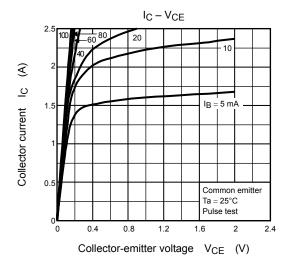
## Electrical Characteristics (Ta = 25°C)

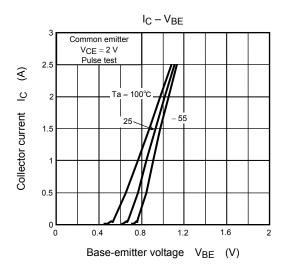
Characteristic		Symbol	Test Conditions	Min	Тур.	Max	Unit
Collector cut-off current		I <sub>CBO</sub>	V <sub>CB</sub> = 160 V, I <sub>E</sub> = 0	_	_	1	μА
Emitter cut-off current		I <sub>EBO</sub>	V <sub>EB</sub> = 9 V, I <sub>C</sub> = 0	-	_	1	μА
Collector-emitter breakdown voltage		V (BR) CEO	I <sub>C</sub> = 10 mA, I <sub>B</sub> = 0	80	_	_	V
DC current gain		h <sub>FE (1)</sub>	V <sub>CE</sub> = 2 V, I <sub>C</sub> = 1 mA	150	_	_	
		h <sub>FE</sub> (2)	V <sub>CE</sub> = 2 V, I <sub>C</sub> = 0.5 A	180	_	450	
		h <sub>FE</sub> (3)	V <sub>CE</sub> = 2 V, I <sub>C</sub> = 1 A	100	_	_	
Collector emitter saturation voltage		V <sub>CE</sub> (sat) (1)	I <sub>C</sub> = 0.5 A, I <sub>B</sub> = 50 mA	_	_	0.3	V
		V <sub>CE</sub> (sat) (2)	I <sub>C</sub> = 1 A, I <sub>B</sub> = 100 mA	_	_	0.5	V
Base-emitter saturation voltage		V <sub>BE</sub> (sat)	I <sub>C</sub> = 1 A, I <sub>B</sub> = 100 mA	_	_	1.5	V
Transition frequency		f <sub>T</sub>	V <sub>CE</sub> = 2 V, I <sub>C</sub> = 0.5 A	_	150	_	$MH_Z$
Collector output capacitance		C <sub>ob</sub>	V <sub>CB</sub> = 10 V, I <sub>E</sub> = 0,f = 1MH <sub>Z</sub>	_	14	_	pF
Switching time Storage	Rise time	t <sub>r</sub>	V <sub>CC</sub> = 24 V	_	0.05	_	
	Storage time	t <sub>stg</sub>		_	0.4	_	μ\$
	Fall time	t <sub>f</sub>	$I_{B1} = -I_{B2} = 100 \text{ mA}$ Duty cycle $\leq 1\%$	_	0.15	_	

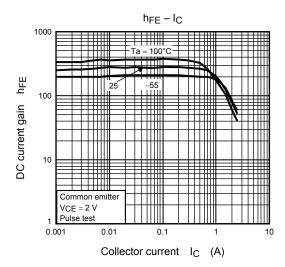
### Marking

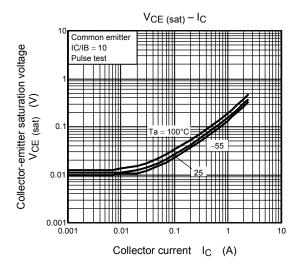


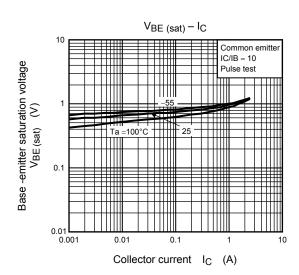
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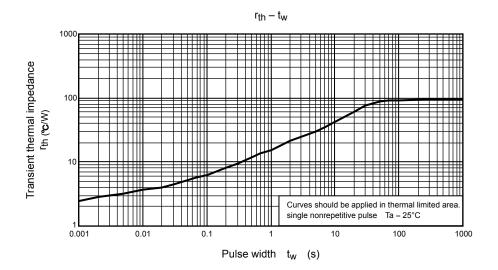


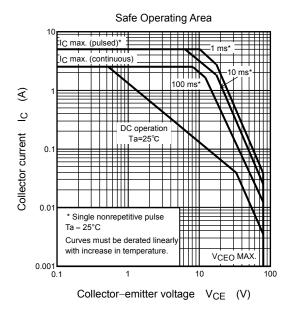






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